Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/963,332	SEPPALA ET AL.	
Examiner	Art Unit	
Dmitry Levitan	2616	

SEARCHED					
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Class	Subclass	Date	Examiner		
370	310		-0/		
	328		76		
	389				
	392		101		
	395.5	2>2/2	100		
455	403				
	422				
	432-				
	435				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
IEEE, EAST	2/2/66	.K		